

Description

This Voltage Controlled Solidtron™ (VCS) discharge switch utilizes an n-type MOS-Controlled Thyristor mounted in a five leaded TO-247 plastic package.

The VCS features the high peak current capability and low On-state voltage drop common to SCR thyristors combined with extremely high di/dt capability. This semiconductor is intended for the control of high power circuits with the use of very small amounts of input energy and is ideally suited for capacitor discharge applications.

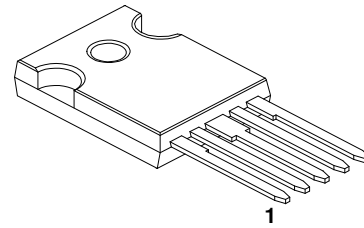
The industry standard TO-247 package allows for integration of the Solidtron using automated insertion equipment.

Features

- 1400V Peak Off-State Voltage
- 65A Continuous Rating
- 6kA Surge Current Capability
- >100kA/uSec di/dt Capability
- <150nSec Turn-On Delay
- Low On-State Voltage
- MOS Gated Control
- Low Inductance Package

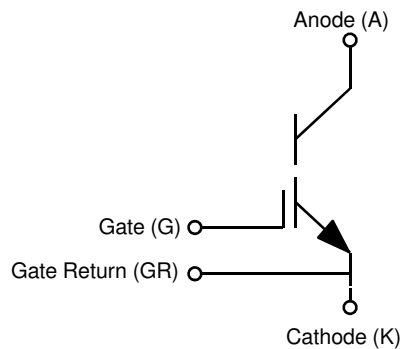
Package

Size - 6



5 Lead TO-247

Schematic Symbol



Absolute Maximum Ratings

	SYMBOL	VALUE	UNITS
Peak Off-State Voltage	V_{DRM}	1400	V
Peak Reverse Voltage	V_{RRM}	-5	V
Off-State Rate of Change of Voltage Immunity	dv/dt	5000	V/uSec
Continuous Anode Current at 110°C	I_{A110}	65	A
Repetitive Peak Anode Current (Pulse Width=1uSec)	I_{ASM}	6000	A
Rate of Change of Current	di/dt	125	kA/uSec
Continuous Gate-Cathode Voltage	V_{GKS}	+/-20	V
Peak Gate-Cathode Voltage	V_{GKM}	+/-25	V
Minimum Negative Gate-Cathode Voltage Required for Garanteed Off-State	$V_{GK(OFF-MIN)}$	-5	V
Maximum Junction Temperature	T_{JM}	150	°C
Maximum Soldering Temperature (Installation)		260	°C

This **SILICON POWER** product is protected by one or more of the following U.S. Patents:

5,521,436	5,446,316	5,105,536	5,209,390	4,958,211	5,206,186	4,857,983	5,082,795	4,644,637
5,585,310	5,557,656	5,777,346	5,139,972	5,111,268	5,757,036	4,888,627	4,980,741	4,374,389
5,248,901	5,564,226	5,446,316	5,103,290	5,260,590	5,777,346	4,912,541	4,941,026	4,750,666
5,366,932	5,517,058	5,577,656	5,028,987	5,350,935	5,995,349	5,424,563	4,927,772	4,429,011
5,497,013	4,814,283	5,473,193	5,304,847	5,640,300	4,801,985	5,399,892	4,739,387	5,293,070
5,532,635	5,135,890	5,166,773	5,569,957	5,184,206	4,476,671	5,468,668	4,648,174	

Performance Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified			Measurements			
Parameters	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Anode to Cathode Breakdown Voltage	$V_{(BR)}$	$V_{GK}=-5, I_A=100\mu\text{A}$	1400			V
Anode-Cathode Off-State Current	i_D	$V_{GE}=-5\text{V}, V_{AK}=1200\text{V}$	$T_C=25^\circ\text{C}$	<1	10	μA
			$T_C=150^\circ\text{C}$	250	1000	μA
Gate-Cathode Turn-On Threshold Voltage	$V_{GK(TH)}$	$V_{AK}=V_{GK}, I_{AK}=1\text{mA}$		0.7		V
Gate-Cathode Leakage Current	$I_{GK(lkg)}$	$V_{GK}=\pm 20\text{V}$			750	nA
Anode-Cathode On-State Voltage	V_T	$I_T=65\text{A}, V_{GK}=+5\text{V}$ (See Figures 1,2 & 3)	$T_C=25^\circ\text{C}$	1.3	1.8	V
			$T_C=150^\circ\text{C}$	1.1	1.4	V
Input Capacitance	C_{ISS}			18		nF
Turn-on Delay Time	$t_{D(ON)}$	0.2 μF Capacitor Discharge		82	150	nS
Rate of Change of Current	di/dt	$T_J=25^\circ\text{C}, V_{GK}=-5\text{V to }+5\text{V}$		>100		kA/ μSec
Peak Anode Current	I_P	$V_{AK}=800\text{V}, R_G=4.7\Omega$		3300		A
Discharge Event Energy	E_{DIS}	$L_S=8\text{nH}$ (See Figures 4,5 & 6)		36		mJ
Turn-on Delay Time	$t_{D(ON)}$	0.2 μF Capacitor Discharge		64	120	nS
Rate of Change of Current	di/dt	$T_J=150^\circ\text{C}, V_{GK}=-5\text{V to }+5\text{V}$		75		kA/ μSec
Peak Anode Current	I_P	$V_{AK}=1200\text{V}, R_G=4.7\Omega$		5200		A
Discharge Event Energy	E_{DIS}	$L_S=8\text{nH}$ (See Figures 4,5 & 6)		74		mJ
Junction to Case Thermal Resistance	$R_{\theta JC}$	Anode (bottom) side cooled (Note 1.)		0.3		$^\circ\text{C/W}$

Notes:

- Case Exterior Assumed to be 0.002" of 63sn/37pb solder applied directly to Anode.

Typical Performance Curves (unless otherwise specified)

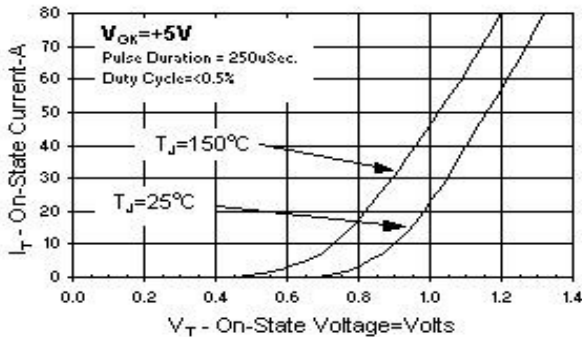


Figure 1. On-State Characteristics

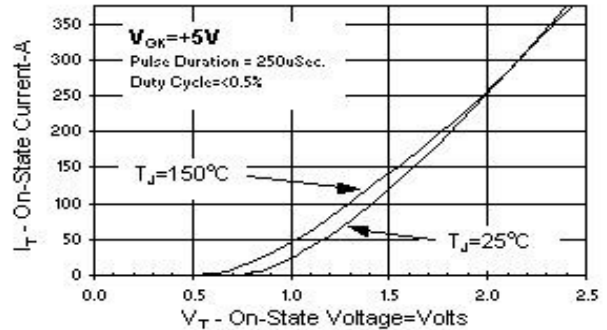


Figure 2. On-State Characteristics

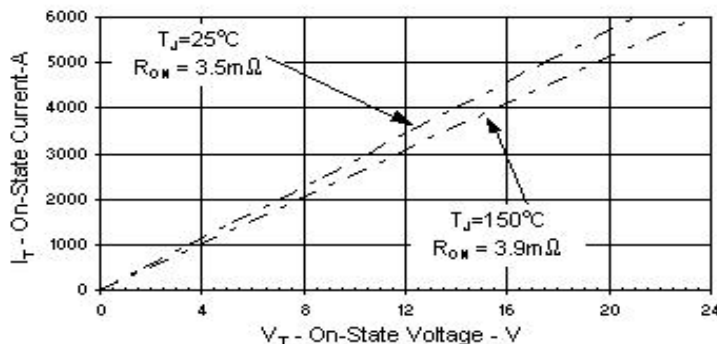


Figure 3. Predicted High Current On-State Characteristics

Typical Performance Curves (Continued)

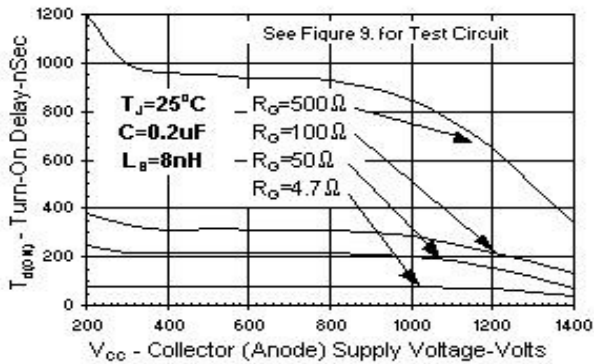


Figure 4. Turn-On Delay Characteristics
 $R_G=4.7\Omega - 500\Omega$, $T_J=25^\circ\text{C}$

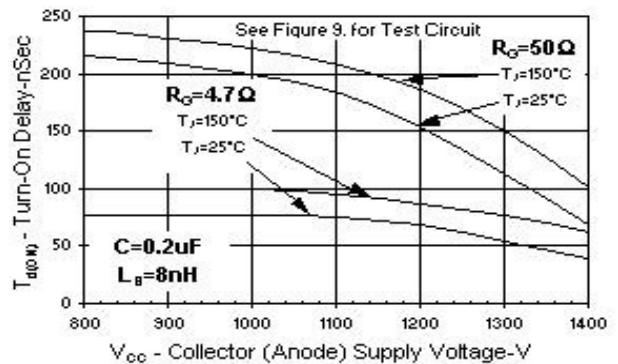


Figure 5. Turn-On Delay Characteristics
 $R_G=4.7\Omega \text{ \& } 50\Omega$, $T_J=25^\circ\text{C} \text{ \& } 150^\circ\text{C}$

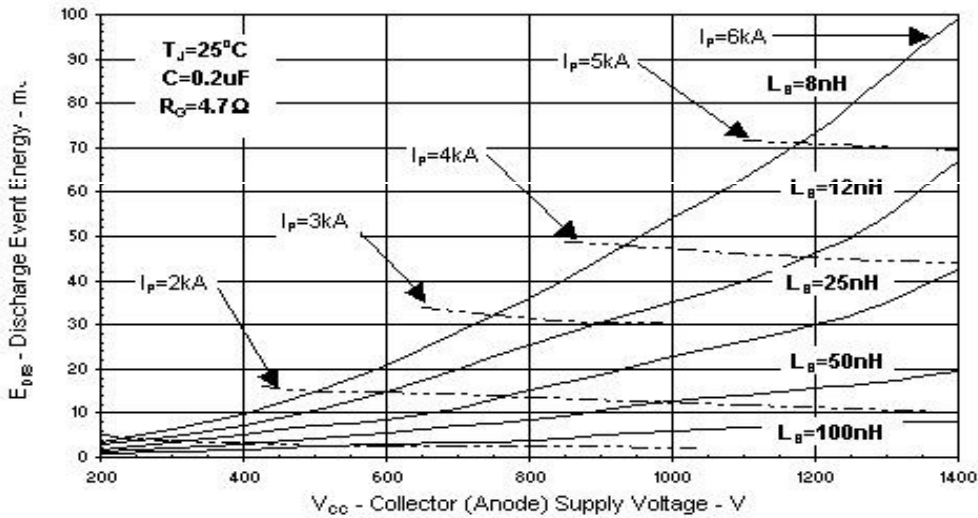


Figure 6. 0.2uF Discharge Pulse Performance Characteristics (See Figure 9.)

Typical Performance Curves (Continued)

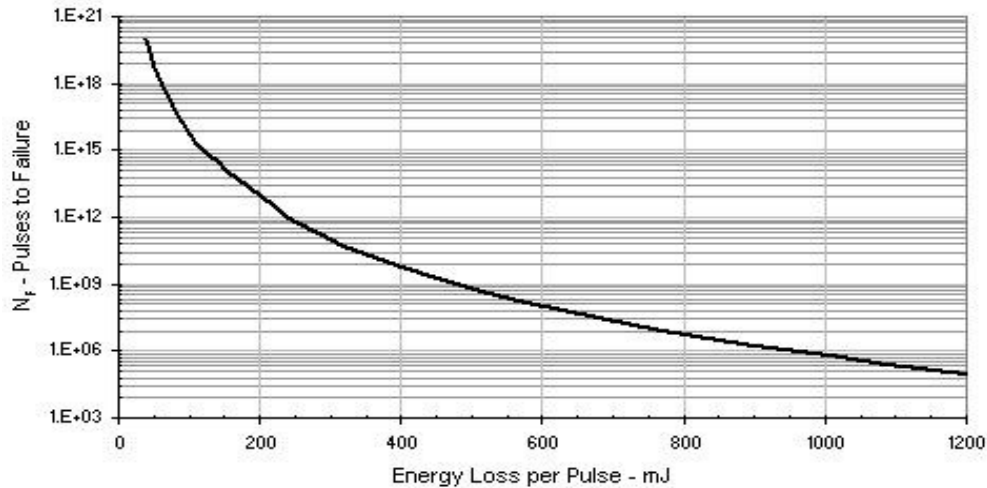
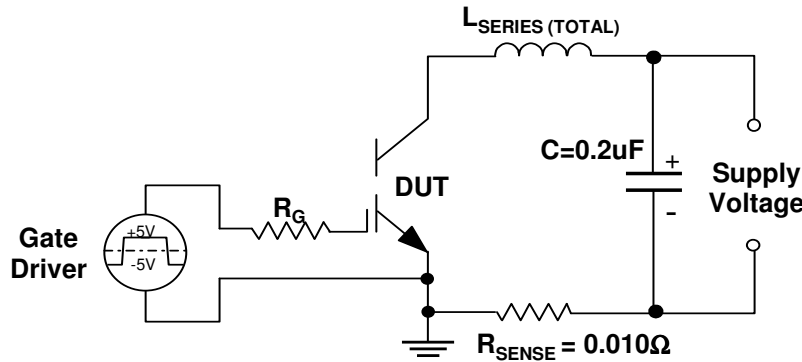


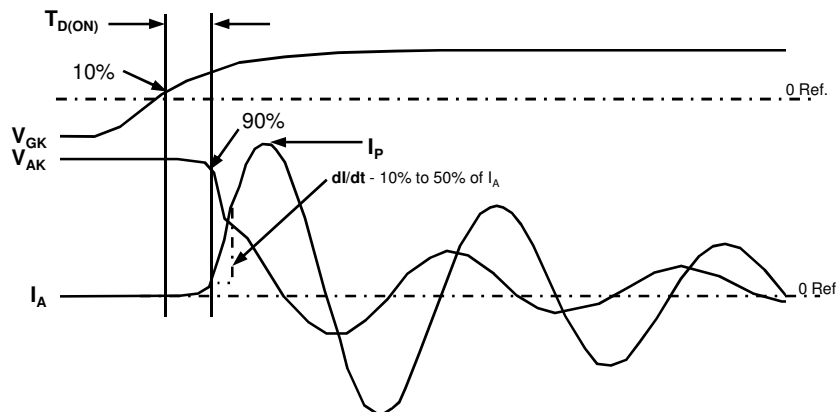
Figure 8. Pulses to Failure (Pulse Widths < 100uSec)

Test Circuit and Waveforms



- $L_{SERIES(TOTAL)}$ is calculated using $1 / (f 2\pi)^2 C$ where f = frequency of I_A (See Figure 10)
- R_{SENSE} is a calibrated Current Viewing Resistor (CVR)

Figure 9. 0.2uF Pulsed Discharge Circuit Schematic



- The waveform shown is representative of one produced using a very low inductance circuit (<10nH).
- V_{GK} is held positive until I_A oscillations have ended ($I_A=0$).

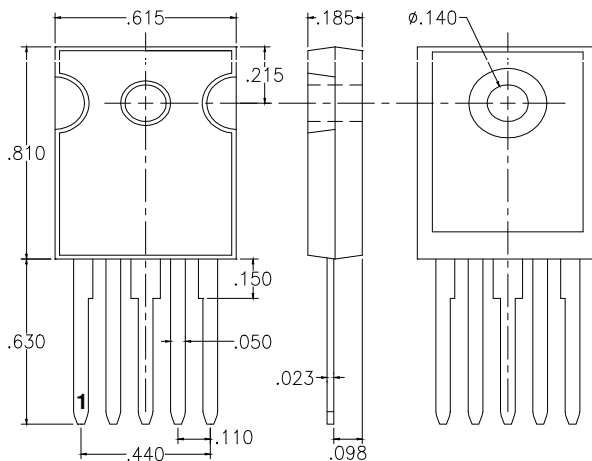
Figure 10. 0.2uF Pulsed Discharge Circuit Waveforms

Application Notes

A1. Use of Gate Return

The VCS was designed for high di/dt applications. An independent cathode connection for use as "gate return" is provided on pin 2 to minimize the effects of rapidly changing Anode-Cathode current on the Gate control voltage, ($V=L \cdot di/dt$). It is therefore, critical that the user utilize the Gate Return as the point at which the gate driver reference (return) is attached to the VCS device.

Packaging and Handling

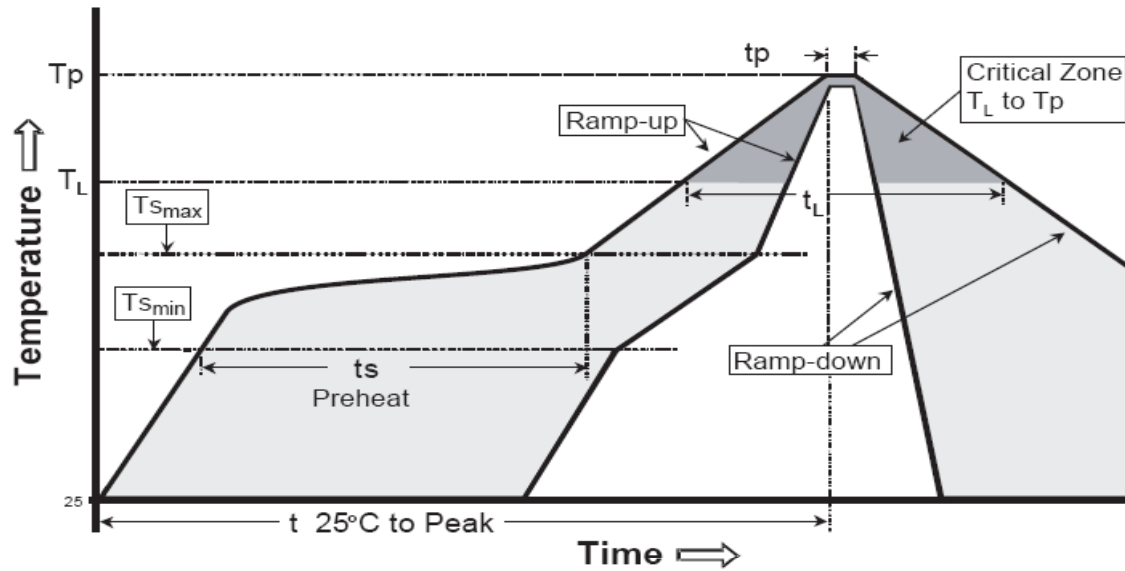


Pin 1 : Gate
Pin 2 : Gate return
Pin 3 : Anode
Pin 4 : Cathode
Pin 5 : Cathode

General Handling Precautions

1. Installation reflow temperature should not exceed 260°C or internal package degradation may result.
2. As with all MOS gated devices, proper handling procedures must be observed to prevent electrostatic discharge which may result in permanent damage to the gate of the device

'ATTENTION OBSERVE PRECAUTIONS FOR HANDLING
ELECTROSTATIC DISCHARGE SENSITIVE DEVICES IN
ALL ASSEMBLY AND TEST AREAS'



IPC-020c-5-1

	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average Ramp-Up Rate (t_{smax} to t_p)	3°C/second max.	3°C/second max.
Preheat		
Temperature Min (t_{smin})	100°C	150°C
Temperature Max (t_{smax})	150°C	200°C
Time (t_{smin} to t_{smax})	60-120 seconds	60-180 seconds
Time maintained above:		
Temperature (t_L)	183°C	217°C
Time (t_L)	60-150 seconds	60-150 seconds
Peak/Classification Temperature (t_p)	240 +0/-5°C	260 +0°C
Temperature (t_p)	10-30 seconds	20-40 seconds
Ramp-Down Rate	6°C/second max.	6°C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Revision History

Rev	Date	EA #	Nature of Change
0	02-15-2008	04242009-NB-0012	Initial Issue